## Temperature dependence of phonon properties in CVD MoS<sub>2</sub> nanostructures – a statistical approach

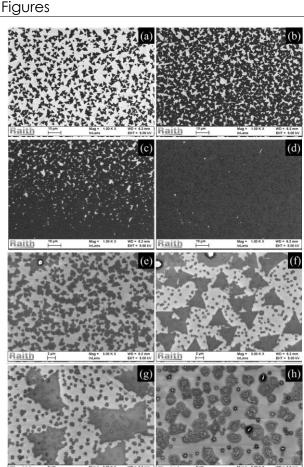
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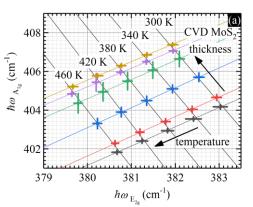
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We report the results of Raman measurements on various molybdenum disulfide nanostructures grown by the chemical vapor deposition method on a Si/SiO<sub>2</sub> substrate. typical The phonon properties investigated include the positions, widths, and intensities of the  $E_{2g}$  and  $A_{1g}$ modes and the derivative of the mode positions with respect to the temperature in the 300 K - 460 K range. Our results bring new insight into changes in phonon energies in response to different disturbances and that changes induced by show the temperature are similar to the changes induced by stress, making these two factors hardly resolvable in the ħω<sub>Α1α</sub>-ħω<sub>Ε2α</sub> coordinate system. We prove that all our samples are weakly coupled to the substrate; thus, the presented results almost purely illustrate the effect of the temperature and thickness. The much stronger coupling to the substrate, however, can explain the high variation in the data reported in the literature. The statistical approach applied makes our results highly reliable and allows proper uncertainty assessment of the obtained results, which is helpful when comparing our results to the results reported by other authors.



aith 2µm Mag= 3.00 KX WD= 62mm Raith 2µm Mag= 3.00 KX WD= 62mm InLans EHT = 5.00 kV

Figure 1: SEM images of a CVD grown  $MoS_2$ sample representing transformations into different types of nanostructures: (a)-(d) – from isolated monolayer flakes into a continuous monolayer with bilayer structures; (e)-(h) – from monolayer flakes into isolated multilayer nanostructures.



**Figure 2:** Temperature dependence of the  $E_{2g}$  and  $A_{1g}$  phonon energies for six specified positions on the sample.

## References

- [1] Su, L., Zhang, Y., Yu, Y., Cao, L., Nanoscale, 6.9 (2014), 4920-4927.
- [2] Najmaei, S., Ajayan, P. M., Lou, J., Nanoscale, 5.20 (2013), 9758-9763.